Search Notes



Application/Control N

10073772

Applicant(s)/Patent Under Reexamination

HAITSMA ET AL.

Art Unit

Examiner Yogesh Paliwal

2135

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	2/2/07	PWK
713	168, 162, 186, 168-181	8/6/07	PWK
Updated	Search	8/6/07	PWK
Updated	Search	11/25/07	PWK
Updated	Search	1/4/08	PWK

SEARCH NOTES

Search Notes	Date	Examiner
Updated Search	8/6/07	PWK
380/54.CCLS. and ((hash\$5 (digital near signature)) with (frame near block))	8/6/07	PWK
Updated Search	11/25/07	PWK
IEEE	1/4/08	PWK
Inventor name search in East	4/09/2008	YP
(713/162,168-181,182,185,186) + Keyword search- see search history printout	4/09/2008	YP
(380/54,55,210,231,232) + Keyword search - see search history printout	4/09/2008	YP
(382/100,190,195,199)+ Keyword search - see search history printout	4/09/2008	YP
(714/704) + Keyword search- see search history printout	4/09/2008	YP
(348/461,467) + Keyword search - see search history printout	4/09/2008	YP
Other keyword searches in East- see search history printout	4/09/2008	YP
Inventor name search in East	10/12/2008	YP
Update (713/162,168-181,182,185,186) + Keyword search- see search history printout	10/12/2008	YP
Update (380/54,55,210,231,232) + Keyword search - see search history printout	10/12/2008	YP
Update (382/100,190,195,199)+ Keyword search - see search history printout	10/12/2008	YP
Update (714/704) + Keyword search- see search history printout	10/12/2008	YP
Update (348/461,467) + Keyword search - see search history printout	10/12/2008	YP
Other keyword searches in East- see search history printout	10/12/2008	YP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
713	168162, 186, 168-181	2/2/07	PWK
380	54 (hash and identif\$7 and reliable and unreliable).CLM.	2/2/07	PWK
713	168162, 186, 168-181 and ((hash\$5 (digital near signature)) with (frame block)).CLM.	8/6/07	PWK
380	54 and ((hash\$5 (digital near signature)) with (frame block)).CLM.	8/6/07	PWK
	(hash and identif\$7 and reliable and unreliable).CLM.	4/09/2008	YP
	(hash and identif\$7 and reliable and unreliable).CLM.	10/12/2008	YP

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